

Search Notes**Application/Control No.**

10/708,331

Examiner

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Applicant(s)/Patent under Reexamination

HSIEH ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	29,30	1/29/2006	JWC
362	613	1/29/2006	JWC
362	632-634	1/29/2006	JWC
362	294	1/29/2006	JWC
349	58,65	1/29/2006	JWC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text 362/\$.ccls.	9/6/2005	JWC
text 349/\$.ccls.	9/6/2005	JWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner